TSSOP56-P-0061-0.50A

Weight: 0.25 g (typ.)

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX16501FT

Low-Voltage 18-Bit Universal Bus Transceiver with 3.6-V Tolerant Inputs and Outputs

The TC74VCX16501FT is a high performance CMOS 18-bit universal bus transceiver. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

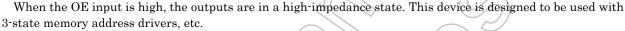
It is also designed with overvoltage tolerant inputs and outputs up to $3.6\ V_{\cdot}$

Data flow in each direction is controlled by output-enable (OEAB and \overline{OEBA}), latch-enable (LEAB and LEBA), and clock (CKAB and CKBA) inputs.

For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CKAB is held at a high or low logic level. If LEAB is low,

the A bus data is stored in the latch/flip-flop on the low-to-high transition of CKAB.

Data flow for B to A is similar to that of A to B but uses OEBA, LEBA, and CKBA.



All inputs are equipped with protection circuits against static discharge.

Features (Note)

- Low-voltage operation: V_{CC} = 1.8 to 3.6 V
- High-speed operation: $t_{pd} = 2.9 \text{ ns (max) (V}_{CC} = 3.0 \text{ to } 3.6 \text{ V)}$

: $t_{pd} = 3.5 \text{ ns (max)} (V_{CC} = 2.3 \text{ to } 2.7 \text{ V})$

 $: t_{pd} = 7.0 \text{ ns (max) (V}_{CC} = 1.8 \text{ V})$

- Output current: $I_{OH}/I_{OL} = \pm 24 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$
 - $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$
 - : $I_{OH}/I_{OL} = \pm 6 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$
- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$

Human body model $\geq \pm 2000 \text{ V}$

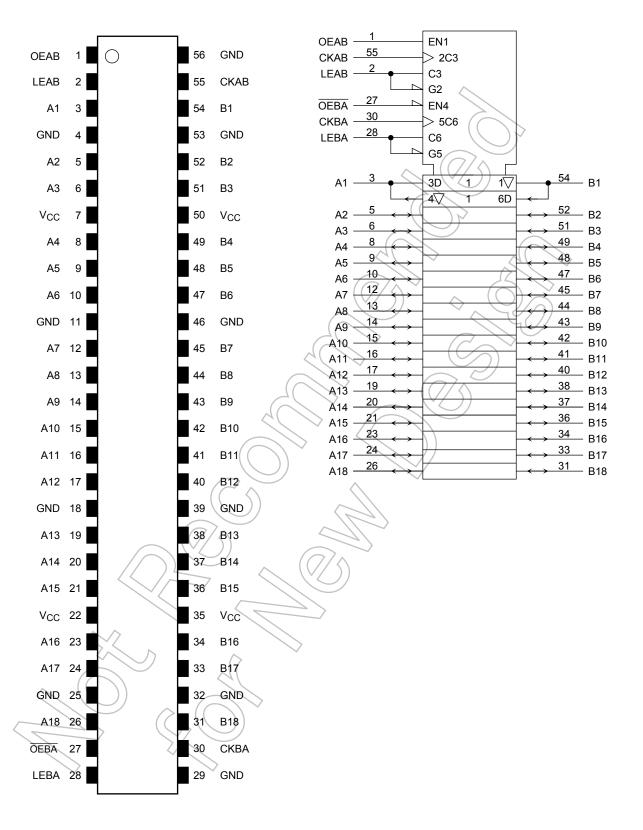
- Package: TSSOP
- Bidirectional interface between 2.5 V and 3.3 V signals.
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

All floating (high impedance) bus pins must have their input level fixed by means of pull-up or pull-down resistors.

Pin Assignment (top view)

IEC Logic Symbol



Truth Table (A bus \rightarrow B bus)

	Inputs						
OEAB	LEAB	CKAB	Α	В			
L	Х	Х	Х	Z			
Н	Н	Х	L	L			
Н	Н	Х	Н	Н			
Н	L		L	L			
Н	L		Н	Н			
Н	L	Н	Х	ВО			
				(Note)			
Н	L	L	Х	ВО			
				(Note)			

Note: Output level before the indicated steady-state input conditions were established, provided that CKAB was low or high before LEAB went low.

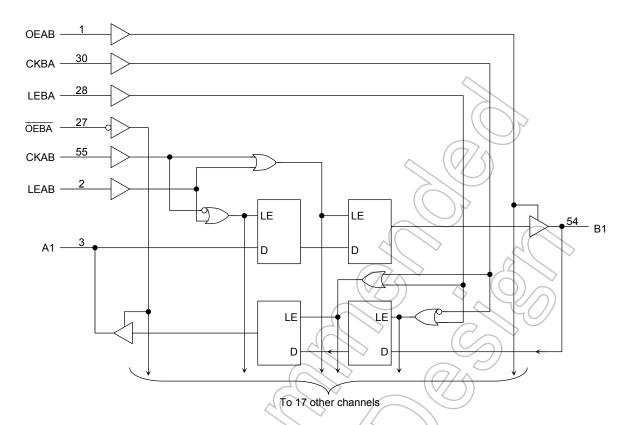
Truth Table (B bus → A bus)

	Inputs							
OEBA	LEBA	CKBA	В	A				
Н	Х	Х	Х	Z				
L	Н	X	L	7				
L	Н	X	нζ	H				
L	L			<u> </u>				
L	L		H)) H				
L	L	Н	X	A0 _				
				(Note)				
L	L	L	X	A0				
		_ ((//	$\langle \langle \rangle$	(Note)				

Note: Output level before the indicated steady-state input conditions were established, provided that CKBA was low or high before LEBA went low.



System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	(V _{CC} \	-0.5 to 4.6	V
DC input voltage (OEAB, OEBA, LEAB, LEBA, CKAB, CKBA)	VIN	-0.5 to 4.6	٧
DC bus I/O voltage	V _{I/O}	-0.5 to V _{CC} + 0.5 (Note 3)	>
Input diode current	lık	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	Po	400	mW
DC V _{CC} /ground current per supply pin	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: Vout < GND, Vout > Vcc

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Dowar aupply voltage	V	1.8 to 3.6	V
Power supply voltage	V _{CC}	1.2 to 3.6 (Note 2)	V
Input voltage (OEAB, OEBA, LEAB, LEBA, CKAB, CKBA)	V _{IN}	-0.3 to 3.6	> (
Bus I/O voltage	V _{I/O}	0 to 3.6 (Note 3)	V.
Bus I/O Vollage	VI/O	0 to V _{CC} (Note 4)	(V//
		±24 (Note 5)	
Output current	I _{OH} /I _{OL}	±18 (Note 6)	mA
		±6 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	>°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

- Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.
- Note 2: Data retention only
- Note 3: OFF state
- Note 4: High or low state
- Note 5: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$
- Note 6: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$
- Note 7: $V_{CC} = 1.8 \text{ V}$
- Note 8: $V_{IN} = 0.8 \text{ to } 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$



Electrical Characteristics

DC Characteristics (Ta = -40 to 85° C, 2.7 V < V_{CC} ≤ 3.6 V)

Character	istics	Symbol	Test Co	ondition	V _{CC} (V)	Min	Max	Unit	
Input voltage	H-level	V _{IH}	_	_	2.7 to 3.6	2.0	_	V	
input voitage	L-level	V _{IL}	_	_	2.7 to 3.6	_	0.8	V	
				$I_{OH} = -100 \mu A$	2.7 to 3.6	V _{CC} - 0.2	_		
	H-level	Voh	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -12 mA	2.7	2.2	_		
				I _{OH} = -18 mA	3.0	2.4	_		
Output voltage				I _{OH} = -24 mA	3.0	2.2	_	V	
		V _{OL}	OL VIN = VIH or VIL	$I_{OL} = 100 \mu\text{A}$	2.7 to 3.6		0.2		
	L-level			I _{OL} = 12 mA	2.7	4	0.4		
	L-ICVCI			I _{OL} = 18 mA	3.0	2	0.4		
				I _{OL} = 24 mA	3.0	D) -	0.55		
Input leakage curre	ent	I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	4	±5.0	μΑ	
3-state output OFF	state current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V		2.7 to 3.6	>_	±10.0	μА	
Power-off leakage	current	loff	V_{IN} , $V_{OUT} = 0$ to 3.6 V) (0)	_	10.0	μΑ	
Quiescent supply o	urrent	loo	$V_{IN} = V_{CC}$ or GND		2.7 to 3.6	_	20.0		
Quiescent supply current		Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6$	SV	2.7 to 3.6	_	±20.0	μΑ	
Increase in I _{CC} per	input	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6	_	750		

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ V_{CC} ≤ 2.7 V)

Characteris	tics	Symbol	Test Co	ondition	V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	ViH			2.3 to 2.7	1.6	_	V
Input voltage	L-level	VIL))	2.3 to 2.7	_	0.7	V
		>		I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	_	
	H-level	V _{OH}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OH} = -6 mA	2.3	2.0	_	
	N n		\wedge	I _{OH} = -12 mA	2.3	1.8	_	٧
Output voltage				I _{OH} = -18 mA	2.3	1.7	_	
				I _{OL} = 100 μA	2.3 to 2.7	_	0.2	
	L-level	> VoL	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 12 mA	2.3	_	0.4	
	(100		I _{OL} = 18 mA	2.3	_	0.6	
Input leakage curren	t	\h\	$V_{IN} = 0$ to 3.6 V		2.3 to 2.7		±5.0	μА
3-state output OFF s	state current	loz	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		2.3 to 2.7	_	±10.0	μА
Power-off leakage co	urrent	loff	V_{IN} , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μΑ
Quiescent supply current		1	$V_{IN} = V_{CC}$ or GND		2.3 to 2.7		20.0	μА
Quiescent supply cu	II GIIL	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6$	V	2.3 to 2.7	-	±20.0	μΑ

DC Characteristics (Ta = -40 to 85°C, 1.8 V \leq V $_{CC}$ < 2.3 V)

Characteris	stics	Symbol	Test Condition		Test Condition		\\ (\(\)	Min	Max	Unit
					V _{CC} (V)					
Input voltage	H-level	V _{IH}	_	_	1.8 to 2.3	$0.7 \times V_{CC}$	_	V		
input voitage	L-level	V _{IL}	_	_	1.8 to 2.3		0.2 × V _{CC}	V		
	H-level	Voh	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -100 \mu A$	1.8	VCC 0.2				
Output voltage				$I_{OH} = -6 \text{ mA}$	71.8	1.4		V		
	Llovol	level V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.8		0.2			
	L-level			I _{OL} = 6 mA	1.8		0.3			
Input leakage currer	nt	I _{IN}	V _{IN} = 0 to 3.6 V		1.8		±5.0	μΑ		
3-state output OFF s	state current	l _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		1.8	(4)	±10.0	μА		
Power-off leakage c	urrent	loff	V_{IN} , $V_{OUT} = 0$ to 3.6 V		0	<u> </u>	> 10.0	μΑ		
Quiescent supply cu	Quiescent cumply current		$V_{IN} = V_{CC}$ or GND		1.8		20.0	Δ		
Quiescent supply cu	ili Gill	lcc ,	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6$	V	1.8		±20.0	μА		

AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, C_L = 30 pF, R_L = 500 Ω) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
			1.8	100		
Maximum clock frequency	f _{max}	Figure 1, Figure 3	2.5 ± 0.2	200		MHz
	illax	- gara , gara c	3.3 ± 0.3	250		
			1.8	1.5	7.0	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	0.8	3.5	ns
(An, Bn-Bn, An)	t _{pHL}		3.3 ± 0.3	0.6	2.9	
			1.8	1.5	8.8	
Propagation delay time	t _{pLH}	Figure 1, Figure 3	2.5 ± 0.2	0.8	4.4	ns
(CKAB, CLKBA-Bn, An)	t _{pHL}		3.3 ± 0.3	0.6	3.5	
			1.8	1,5	9.8	
Propagation delay time	t _{pLH}	Figure 1, Figure 4	2.5 ± 0.2	0.8	4.9	ns
(LEAB, LEBA-Bn, An)	t _{pHL}	(\bigcirc / \bigcirc)	3.3 ± 0.3	0.6	3.8	
	_		1.8	(1,5)	9.8	
Output enable time	t _{pZL}	Figure 1, Figure 5, Figure 6	2.5 ± 0.2	0.8	4.9	ns
(OEAB, OEBA -Bn, An)		400	3.3 ± 0.3	0.6	3.8	
Outrot dischie the	4	Figure 1, Figure 5, Figure 6	1.8	1.5	7.6	ns
Output disable time (OEAB, OEBA -Bn, An)	t _{pLZ}		2.5 ± 0.2	0.8	4.2	
(OEAB, OEBA-BII, AII)	t _{pHZ}	4()	3.3 ± 0.3	0.6	3.7	
	4		1.8	4.0	_	
Minimum pulse width	tw (H)	Figure 1, Figure 3, Figure 4	2.5 ± 0.2	1.5	_	ns
	t _W (L)		3.3 ± 0.3	1.5	_	
			1.8	2.5	_	
Minimum set-up time	ts	Figure 1, Figure 3, Figure 4	2.5 ± 0.2	1.5	_	ns
			3.3 ± 0.3	1.5	_	
) /	$\langle \langle \langle // \rangle \rangle$	1.8	1.0	_	
Minimum hold time	th	Figure 1, Figure 3, Figure 4	2.5 ± 0.2	1.0	_	ns
	>		3.3 ± 0.3	1.0	_	
$\langle \rangle$	t _{osLH}		1.8	_	0.5	ns
Output to output skew	t _{osHL}	(Note 2)	2.5 ± 0.2	_	0.5	
	40SFIL	(3.3 ± 0.3	_	0.5	

Note 1: For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics (Ta = 25°C, input: t_r = t_f = 2.0 ns, C_L = 30 pF, R_L = 500 Ω)

Characteristics	Symbol	Test Condition $V_{CC}(V)$			Тур.	Unit
		V 40VV 0V	(11-4-)		0.05	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	1.8	0.25	
Quiet output maximum dynamic V _{OL}	V _{OLP}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	2.5	0.6	V
OL .		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	8.0	
	V _{OLV}	V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	-0.25	
Quiet output minimum dynamic V _{OL}		V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	-0.6	V
OL .		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	-0.8	
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	1.5	
Quiet output minimum dynamic VOH	V _{OHV}	V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	1.9	V
011		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	2.2	

Note: Parameter guaranteed by design.

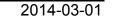
Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}		7/	1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C _{I/O}	-		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating Note: current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/18$ (per bit)



AC Test Circuit

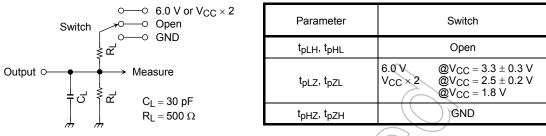


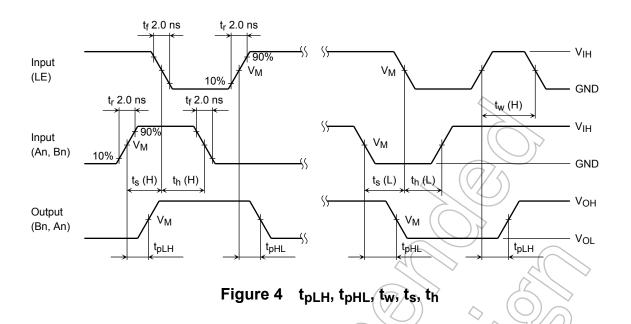
Figure 1 **AC Waveform** t_r 2.0 ns t_f 2.0 ns Ŋ'n Input (An, Bn) GND Von Output V_{M} (Bn, An) V_{OL} ^tpHL tpLH Figure 2 tpLH, tpHL t_r 2.0 ns $\langle t_f$ 2.0 ns V_{IH} 90% Input (CKAB, CKBA) 10% **GND** $t_{W}\left(L\right)$ $t_{w}(H)$ · V_{IH} Input V_{M} (An, Bn) **GND** t_s (H) t_h (H) t_s (L) t_h (L) - Voh Output (Bn, An) - V_{OL}

Figure 3 t_{pLH} , t_{pHL} , t_w , t_s , t_h

10

 t_{pLH}

tpHL



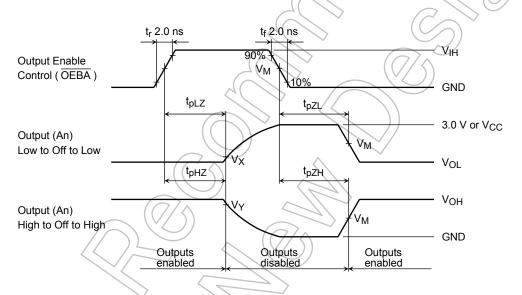


Figure 5 t_{pLZ}, t_{pHZ}, t_{pZL}, t_{pZH}

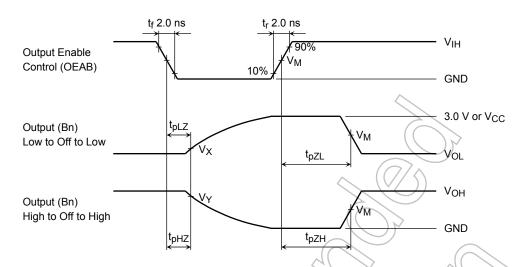
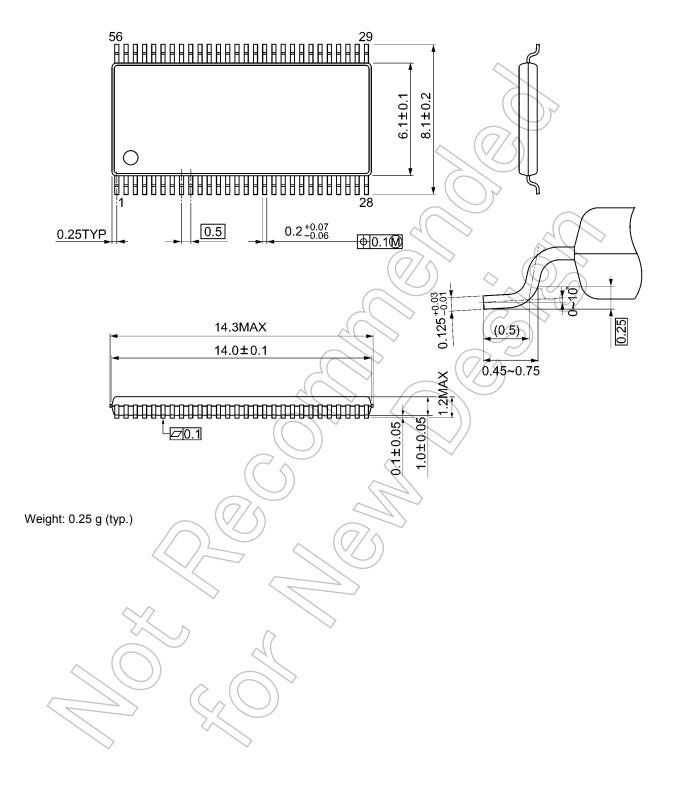


Figure 6 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

			<i></i>						
Symbol		Vcc							
Syllibol	$3.3\pm0.3~\textrm{V}$	2.5 ± 0.2 V	1.8 V						
V_{IH}	2.7 V	Vcc	V _{CC}						
V _M	1.5 V	V _{CC} /2	Vcc/2						
VX	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V						
VY	V _{OH} – 0.3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V						

Package Dimensions

TSSOP56-P-0061-0.50A Unit: mm



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